

<b>Notice of References Cited</b>	Application/Control No. 10/582,852		Applicant(s)/Patent Under Reexamination ONISHI ET AL.	
	Examiner OMONIYI A. OBAYANJU		Art Unit 2617	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0019960	09-2001	Takayama et al.	455/456
*	B	US-2004/0059498	03-2004	Chinomi et al.	701/200
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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